


<b>Search Notes</b>  	<b>Application/Control No.</b>  10533420	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Yelena G Gakh, Ph.D.	<b>Art Unit</b>  1797

SEARCHED			
Class	Subclass	Date	Examiner
436	2, 4, 163, 174,180 (text search)	1/31/2011	YG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (attached), search for PCT/US03/35012, inventors' names search, Google	11/21/2008	YG
EAST (updated attached)	9/25/2009	YG
EAST (updated)	1/31/2011	YG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
436	2, 4, 163, 174,180	9/25/2009	YG
	updated	1/31/2011	YG

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